# Silicon P Channel MOS FET High Speed Power Switching

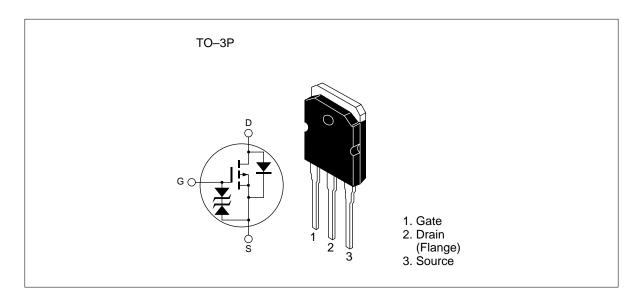
# **HITACHI**

ADE-208-634A (Z) 2nd. Edition Jun 1998

#### **Features**

- Low on-resistance  $R_{DS(on)} = 0.017\Omega \ typ. \label{eq:DSon}$
- Low drive current.
- 4V gate drive devices.
- High speed switching.

#### Outline



# **Absolute Maximum Ratings** $(Ta = 25^{\circ}C)$

Item	Symbol	Ratings	Unit
Drain to source voltage	$V_{\scriptscriptstyle DSS}$	-60	V
Gate to source voltage	V <sub>GSS</sub>	±20	V
Drain current	I <sub>D</sub>	-60	A
Drain peak current	I Note1	-240	A
Body-drain diode reverse drain current	I <sub>DR</sub>	-60	A
Avalanche current	I Note3	-60	A
Avalanche energy	E <sub>AR</sub> Note3	308	mJ
Channel dissipation	Pch Note2	125	W
Channel temperature	Tch	150	°C
Storage temperature	Tstg	-55 to +150	°C

Note: 1. PW  $\leq$  10  $\mu$ s, duty cycle  $\leq$  1 %

2. Value at  $Tc = 25^{\circ}C$ 

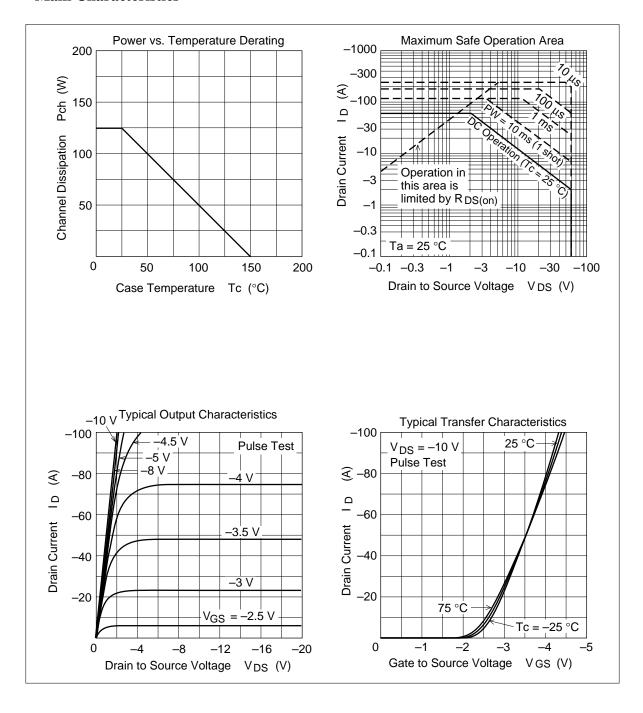
3. Value at Tch = 25°C, Rg  $\geq$  50  $\Omega$ 

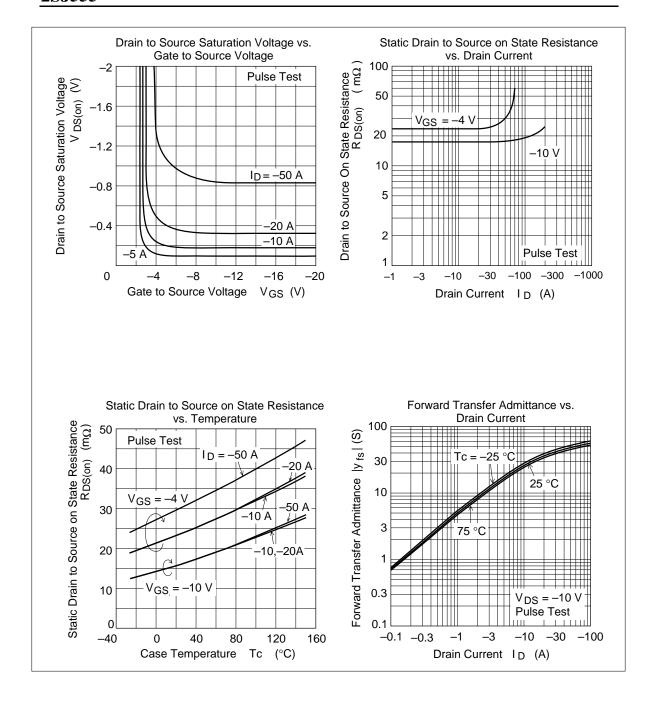
#### **Electrical Characteristics** (Ta = 25°C)

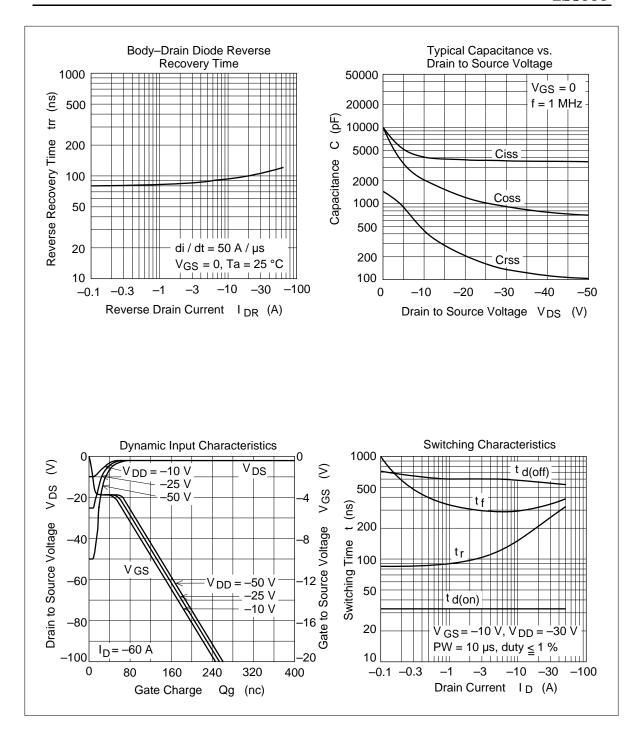
Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	-60	_	_	V	$I_D = -10 \text{mA}, V_{GS} = 0$
Gate to source breakdown voltage	V <sub>(BR)GSS</sub>	±20	_	_	V	$I_{G} = \pm 100 \mu A, V_{DS} = 0$
Zero gate voltege drain current	I <sub>DSS</sub>	_	_	-10	μΑ	$V_{DS} = -60 \text{ V}, V_{GS} = 0$
Gate to source leak current	I <sub>GSS</sub>	_	_	±10	μΑ	$V_{GS} = \pm 16V, V_{DS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	-1.0	_	-2.0	V	$I_{D} = -1 \text{mA}, V_{DS} = -10 \text{V}$
Static drain to source on state	R <sub>DS(on)</sub>	_	0.017	0.022	Ω	$I_D = -30A, V_{GS} = -10V^{Note4}$
resistance	R <sub>DS(on)</sub>	_	0.024	0.036	Ω	$I_D = -30A, V_{GS} = -4V^{Note4}$
Forward transfer admittance	y <sub>fs</sub>	27	45	_	S	$I_{D} = -30A, V_{DS} = -10V^{Note4}$
Input capacitance	Ciss	_	4100	_	pF	$V_{DS} = -10V$
Output capacitance	Coss	_	2100	_	pF	$V_{GS} = 0$
Reverse transfer capacitance	Crss	_	450	_	pF	f = 1MHz
Turn-on delay time	t <sub>d(on)</sub>	_	32	_	ns	$V_{GS} = -10V, I_{D} = -30A$
Rise time	t,	_	270	_	ns	$R_L = 1\Omega$
Turn-off delay time	t <sub>d(off)</sub>	_	570	_	ns	
Fall time	t <sub>f</sub>	_	360	_	ns	
Body-drain diode forward voltage	$V_{DF}$	_	-1.1	_	V	$I_F = -60A, V_{GS} = 0$
Body-drain diode reverse recovery time	t <sub>rr</sub>	_	115		ns	$I_F = -60A, V_{GS} = 0$ diF/ dt =50A/ $\mu$ s

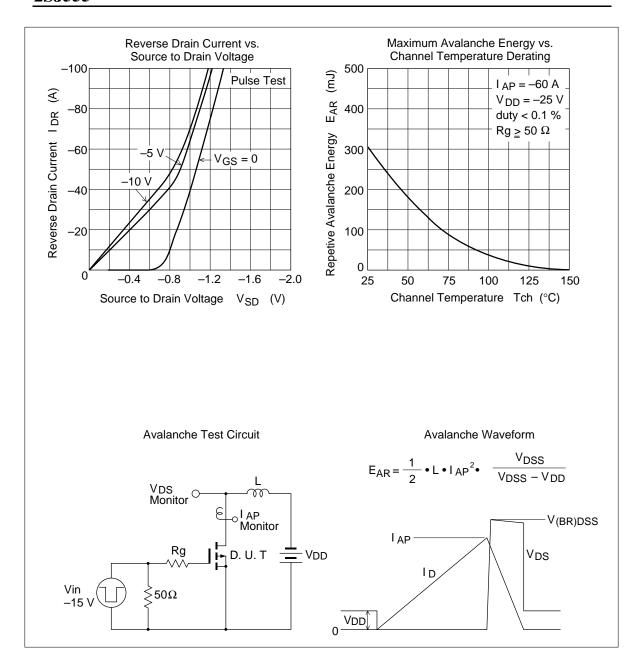
Note: 4. Pulse test

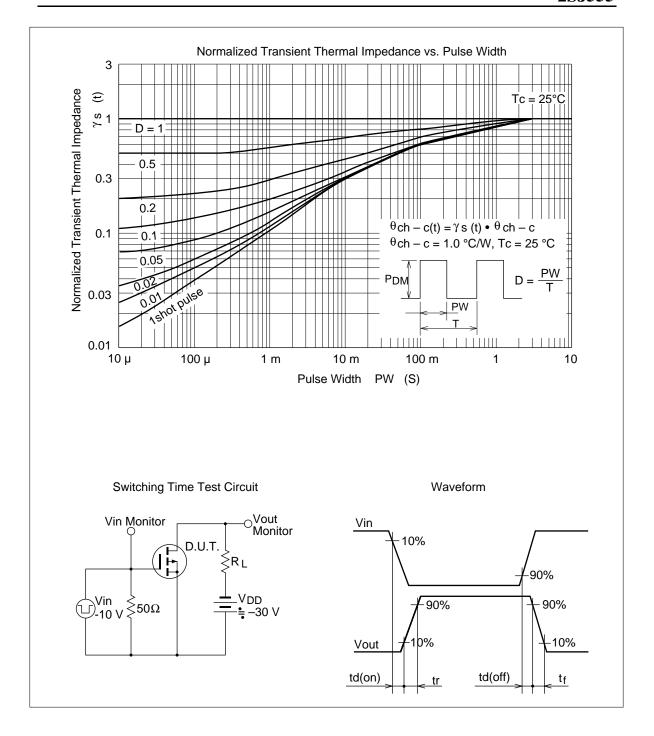
#### **Main Characteristics**





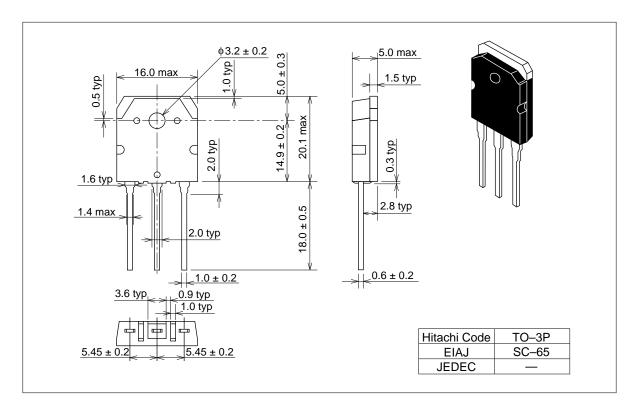






# **Package Dimensions**

Unit: mm



#### **Cautions**

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